





Application/Control No.	Applicant(s)/Patent under Reexamination	
0/662 638	MAYEGA ET AL	

 10/662,638
 MAYEGA ET AL

 Examiner
 Art Unit

Tuan T. Lam 2816

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Class	Subclass	Date	Examiner		
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INT	TERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
See attachment	8(10)06	T.la
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